

On the Design of LIL Tests for (Pseudo) Random Generators and Some Experimental Results

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Abstract—Random numbers have been one of the most useful objects in statistics, computer science, cryptography, modeling, simulation, and other applications though it is very difficult to construct true randomness. Many solutions (e.g., cryptographic pseudorandom generators) have been proposed to harness or simulate randomness and many statistical testing techniques have been proposed to determine whether a pseudorandom generator produces high quality randomness. NIST SP800-22 (2010) proposes the state of art testing suite for (pseudo) random generators to detect deviations of a binary sequence from randomness. On the one hand, as a counter example to NIST SP800-22 test suite, it is easy to construct functions that are considered as GOOD pseudorandom generators by NIST SP800-22 test suite though the output of these functions are easily distinguishable from the uniform distribution. Thus these functions are not pseudorandom generators by definition. On the other hand, NIST SP800-22 does not cover some of the important laws for randomness. Two fundamental limit theorems about random binary strings are the central limit theorem and the law of the iterated logarithm (LIL). Several frequency related tests in NIST SP800-22 cover the central limit theorem while no NIST SP800-22 test covers LIL.

This paper proposes techniques to address the above challenges that NIST SP800-22 testing suite faces. Firstly, we propose statistical distance based testing techniques for (pseudo) random generators to reduce the above mentioned Type II errors in NIST SP800-22 test suite. Secondly, we propose LIL based statistical testing techniques, calculate the probabilities, and carry out experimental tests on widely used pseudorandom generators by generating around 30TB of pseudorandom sequences. The experimental results show that for a sample size of 1000 sequences (2TB), the statistical distance between the generated sequences and the uniform distribution is around 0.07 (with 0 for statistically indistinguishable and 1 for completely distinguishable) and the root-mean-square deviation is around 0.005. Though the statistical distance 0.07 and RMSD 0.005 are acceptable for some applications, for a cryptographic “random oracle”, the preferred statistical distance should be smaller than 0.03 and RMSD be smaller than 0.001 at the sample size 1000. These results justify the importance of LIL testing techniques designed in this paper. The experimental results in this paper are reproducible and the raw experimental data are available at author’s website.

I. INTRODUCTION

Secure cryptographic hash functions such as SHA1, SHA2, and SHA3 and symmetric key block ciphers (e.g., AES and TDES) have been commonly used to design pseudorandom generators with counter modes (e.g., in Java Crypto Library and in NIST SP800-90A standards). Though security of hash functions such as SHA1, SHA2, and SHA3 has been extensively studied from the one-wayness and collision resistant

aspects, there has been limited research on the quality of long pseudorandom sequences generated by cryptographic hash functions. Even if a hash function (e.g., SHA1) performs like a random function based on existing statistical tests (e.g., NIST SP800-22 Revision 1A [17]), when it is called many times for a long sequence generation, the resulting long sequence may not satisfy the properties of pseudorandomness and could be distinguished from a uniformly chosen sequence. For example, the recent reports from New York Times [16] and The Guardian [1] show that NSA has included back doors in NIST SP800-90A pseudorandom bit generators (on which our experiments are based on) to get online cryptanalytic capabilities.

Statistical tests are commonly used as a first step in determining whether or not a generator produces high quality random bits. For example, NIST SP800-22 Revision 1A [17] proposed the state of art statistical testing techniques for determining whether a random or pseudorandom generator is suitable for a particular cryptographic application. NIST SP800-22 includes 15 tests: frequency (monobit), number of 1-runs and 0-runs, longest-1-runs, binary matrix rank, discrete Fourier transform, template matching, Maurer’s “universal statistical” test, linear complexity, serial test, the approximate entropy, the cumulative sums (cusums), the random excursions, and the random excursions variants. In a statistical test of [17], a significance level $\alpha \in [0.001, 0.01]$ is chosen for each test. For each input sequence, a P -value is calculated and the input string is accepted as pseudorandom if P -value $\geq \alpha$. A pseudorandom generator is considered good if, with probability α , the sequences produced by the generator fail the test. For an in-depth analysis, NIST SP800-22 recommends additional statistical procedures such as the examination of P -value distributions (e.g., using χ^2 -test).

NIST SP800-22 test suite has inherent limitations with straightforward Type II errors. For example, for a function F that mainly outputs “random strings” but, with probability α , outputs biased strings (e.g., strings consisting mainly of 0’s), F will be considered as a “good” pseudorandom generator by NIST SP800-22 test though the output of F could be distinguished from the uniform distribution (thus, F is not a pseudorandom generator by definition). In the following, we use two examples to illustrate this kind of Type II errors. Let $\text{RAND}_{c,n}$ be the sets of Kolmogorov c -random binary strings of length n , where $c \geq 1$. That is, for a universal Turing

machine M , let

$$\text{RAND}_{c,n} = \{x \in \{0, 1\}^n : \text{if } M(y) = x \text{ then } |y| \geq |x| - c\}. \quad (1)$$

Let α be a given significance level of NIST SP800-22 test and $\mathcal{R}_{2n} = \mathcal{R}_1 \cup \mathcal{R}_2$ where \mathcal{R}_1 is a size $2^n(1 - \alpha)$ subset of $\text{RAND}_{2,2n}$ and \mathcal{R}_2 is a size $2^n\alpha$ subset of $\{0^n x : x \in \{0, 1\}^n\}$. Furthermore, let $f_n : \{0, 1\}^n \rightarrow \mathcal{R}_{2n}$ be an ensemble of random functions (not necessarily computable) such that $f(x)$ is chosen uniformly at random from \mathcal{R}_{2n} . Then for each n -bit string x , with probability $1 - \alpha$, $f_n(x)$ is Kolmogorov 2-random and with probability α , $f_n(x) \in \mathcal{R}_2$. Since all Kolmogorov 2-random strings are guaranteed to pass NIST SP800-22 test at significance level α (otherwise, they are not Kolmogorov 2-random by definition) and all strings in \mathcal{R}_2 fail NIST SP800-22 test at significance level α for large enough n , the function ensemble $\{f_n\}_{n \in \mathbb{N}}$ is considered as a “good” pseudorandom generator by NIST SP800-22 test suite. On the other hand, Theorem 3.2 in Wang [24] shows that $\text{RAND}_{2,2n}$ (and \mathcal{R}_1) could be efficiently distinguished from the uniform distribution with a non-negligible probability. A similar argument could be used to show that \mathcal{R}_{2n} could be efficiently distinguished from the uniform distribution with a non-negligible probability. In other words, $\{f_n\}_{n \in \mathbb{N}}$ is not a cryptographically secure pseudorandom generator.

As another example, let $\{f'_n\}_{n \in \mathbb{N}}$ be a pseudorandom generator with $f'_n : \{0, 1\}^n \rightarrow \{0, 1\}^{l(n)}$ where $l(n) > n$. Assume that $\{f'_n\}_{n \in \mathbb{N}}$ is a good pseudorandom generator by NIST SP800-22 in-depth statistical analysis of the P-value distributions (e.g., using χ^2 -test). Define a new pseudorandom generators $\{f_n\}_{n \in \mathbb{N}}$ as follows:

$$f_n(x) = \begin{cases} f'_n(x) & \text{if } f'_n(x) \text{ contains more 0's than 1's} \\ f'_n(x) \oplus 1^{l(n)} & \text{otherwise} \end{cases} \quad (2)$$

Then it is easy to show that $\{f_n\}_{n \in \mathbb{N}}$ is also a good pseudorandom generator by NIST SP800-22 in-depth statistical analysis of the P-value distributions (e.g., using χ^2 -test). However, the output of $\{f_n\}_{n \in \mathbb{N}}$ is trivially distinguishable from the uniform distribution.

The above two examples show the limitation of testing approaches specified in NIST SP800-22. The limitation is mainly due to the fact that NIST SP800-22 does not fully realize the differences between the two common approaches to pseudorandomness definitions as observed and analyzed in Wang [24]. In other words, the definition of pseudorandom generators is based on the indistinguishability concepts though techniques in NIST SP800-22 mainly concentrate on the performance of individual strings. In this paper, we propose testing techniques that are based on statistical distances such as root-mean-square deviation or Hellinger distance. The statistical distance based approach is more accurate in deviation detection and avoids above type II errors in NIST SP800-22. Our approach is illustrated using the LIL test design.

Feller [6] mentioned that the two fundamental limit theorems of random binary strings are the central limit theorem and the law of the iterated logarithm. Feller [6] also called

attention to the study of the behavior of the maximum of the absolute values of the partial sums $\bar{S}_n = \frac{\max_{1 \leq k \leq n} |2S(\xi \upharpoonright k)| - n}{\sqrt{n}}$ and Erdos and Kac [5] obtained the limit distribution of \bar{S}_n . NIST SP800-22 test suite includes several frequency related tests that cover the first central limit theorem and the cusum test, “the cumulative sums (cusums) test”, that covers the limit distribution of \bar{S}_n . However it does not include any test for the important law of the iterated logarithm. Thus it is important to design LIL based statistical tests. The law of the iterated logarithm (LIL) says that, for a pseudorandom sequence ξ , the value $S_{lil}(\xi[0..n - 1])$ (this value is defined in Theorem 3.3) should stay in $[-1, 1]$ and reach both ends infinitely often when n increases. It is known [21], [22], [23] that polynomial time pseudorandom sequences follow LIL. It is also known [7] that LIL holds for uniform distributions. Thus LIL should hold for both Kolmogorov complexity based randomness and for “behavioristic” approach based randomness.

This paper designs LIL based weak, strong, and snapshot statistical tests and obtains formulae for calculating the probabilities that a random sequence passes the LIL based tests. We have carried out some experiments to test outcomes of several commonly used pseudorandom generators. In particular, we generated 30TB of sequences using several NIST recommended pseudorandom generators. Our results show that at the sample size 1000 (or 2TB of data), sequences produced by several commonly used pseudorandom generators have a LIL based statistical distance 0.07 from true random sources. On the other hand, at the sample size 10000 (20TB of data), sequences produced by NIST-SHA256 based pseudorandom generators have a LIL based statistical distance 0.02 from true random sources. These distances are larger than expected for cryptographic applications.

The paper is organized as follows. Section II introduces notations. Section III discusses the law of iterated logarithms (LIL). Section IV reviews the normal approximation to binomial distributions. Sections V, VI, and VII propose weak and strong LIL tests. Section VIII describes the steps to evaluate a pseudorandom generator. Section introduces Snapshot LIL tests. Section X reports experimental results and we conclude with Section XI.

II. NOTATIONS AND PSEUDORANDOM GENERATORS

In this paper, \mathbb{N} and \mathbb{R}^+ denotes the set of natural numbers (starting from 0) and the set of non-negative real numbers, respectively. $\Sigma = \{0, 1\}$ is the binary alphabet, Σ^* is the set of (finite) binary strings, Σ^n is the set of binary strings of length n , and Σ^∞ is the set of infinite binary sequences. The length of a string x is denoted by $|x|$. λ is the empty string. For strings $x, y \in \Sigma^*$, xy is the concatenation of x and y , $x \sqsubseteq y$ denotes that x is an initial segment of y . For a sequence $x \in \Sigma^* \cup \Sigma^\infty$ and a natural number $n \geq 0$, $x \upharpoonright n = x[0..n - 1]$ denotes the initial segment of length n of x ($x \upharpoonright n = x[0..n - 1] = x$ if $|x| \leq n$) while $x[n]$ denotes the n th bit of x , i.e., $x[0..n - 1] = x[0] \dots x[n - 1]$. For a set \mathbf{C} of infinite sequences, $\text{Prob}[\mathbf{C}]$ denotes the probability that $\xi \in \mathbf{C}$ when ξ is chosen by a

uniform random experiment. Martingales are used to describe betting strategies in probability theory.

Definition 2.1: (Ville [19]) A martingale is a function $F : \Sigma^* \rightarrow R^+$ such that, for all $x \in \Sigma^*$,

$$F(x) = \frac{F(x1) + F(x0)}{2}.$$

We say that a martingale F *succeeds* on a sequence $\xi \in \Sigma^\infty$ if $\limsup_n F(\xi[0..n-1]) = \infty$.

The concept of “effective similarity” by Goldwasser and Micali [10] and Yao [25] is defined as follows: Let $X = \{X_n\}_{n \in N}$ and $Y = \{Y_n\}_{n \in N}$ be two probability ensembles such that each of X_n and Y_n is a distribution over Σ^n . We say that X and Y are computationally (or statistically) indistinguishable if for every feasible algorithm A (or every algorithm A), the total variation difference between X_n and Y_n is a negligible function in n .

Definition 2.2: Let $\{X_n\}_{n \in N}$ and $\{Y_n\}_{n \in N}$ be two probability ensembles. $\{X_n\}_{n \in N}$ and $\{Y_n\}_{n \in N}$ are computationally (respectively, statistically) indistinguishable if for any polynomial time computable set $D \in \Sigma^*$ (respectively, any set $D \in \Sigma^*$) and any polynomial p , the inequality (3) holds for almost all n .

$$|\text{Prob}[A(X_n) = 1] - \text{Prob}[A(Y_n) = 1]| \leq \frac{1}{p(n)} \quad (3)$$

Let $l : N \rightarrow N$ with $l(n) \geq n$ for all $n \in N$ and G be a polynomial-time computable algorithm such that $|G(x)| = l(|x|)$ for all $x \in \Sigma^*$.

Then the pseudorandom generator concept [3], [25] is defined as follows.

Definition 2.3: Let $l : N \rightarrow N$ with $l(n) > n$ for all $n \in N$, and $\{U_n\}_{n \in N}$ be the uniform distribution. A pseudorandom generator is a polynomial-time algorithm G with the following properties:

- 1) $|G(x)| = l(|x|)$ for all $x \in \Sigma^*$.
- 2) The ensembles $\{G(U_n)\}_{n \in N}$ and $\{U_n\}_{n \in N}$ are computationally indistinguishable.

Let $\text{RAND}_c = \cup_{n \in N} \text{RAND}_{c,n}$ where $\text{RAND}_{c,n}$ is the set of Kolmogorov c -random sequences that is defined in equation (1). Then we have

Theorem 2.4: ([24, Theorem 3.2]) The ensemble $R_c = \{R_{c,n}\}_{n \in N}$ is not pseudorandom.

Theorem 2.4 shows the importance for a good pseudorandom generator to fail each statistical test with certain given probability.

III. STOCHASTIC PROPERTIES OF LONG PSEUDORANDOM SEQUENCES

Classical infinite random sequences were first introduced as a type of disordered sequences, called “Kollektivs”, by von Mises [20] as a foundation for probability theory. The two features characterizing a Kollektiv are: the existence of limiting relative frequencies within the sequence and the invariance of these limits under the operation of an “admissible place selection”. Here an admissible place selection is a procedure for selecting a subsequence of a given sequence ξ in such a way that the decision to select a term $\xi[n]$ does not depend on the value of $\xi[n]$. Ville [19] showed that von

Mises’ approach is not satisfactory by proving that: for each countable set of “admissible place selection” rules, there exists a “Kollektiv” which does not satisfy the law of the iterated logarithm (LIL). Later, Martin-Löf [14] developed the notion of random sequences based on the notion of typicalness. A sequence is typical if it is not in any *constructive* null sets. Schnorr [18] introduced p -randomness concepts by defining the *constructive* null sets as polynomial time computable measure 0 sets. The law of the iterated logarithm (LIL) plays a central role in the study of the Wiener process and Wang [23] showed that LIL holds for p -random sequences.

Computational complexity based pseudorandom sequences have been studied extensively in the literature. For example, p -random sequences are defined by taking each polynomial time computable martingale as a statistical test.

Definition 3.1: (Schnorr [18]) An infinite sequence $\xi \in \Sigma^\infty$ is p -random (polynomial time random) if for any polynomial time computable martingale F , F does not succeed on ξ .

A sequence $\xi \in \Sigma^\infty$ is Turing machine computable if there exists a Turing machine M to calculate the bits $\xi[0], \xi[1], \dots$. In the following, we prove a theorem which says that, for each Turing machine computable non p -random sequence ξ , there exists a martingale F such that the process of F succeeding on ξ can be efficiently observed in time $O(n^2)$. The theorem is useful in the characterizations of p -random sequences and in the characterization of LIL-test waiting period.

Theorem 3.2: ([23]) For a sequence $\xi \in \Sigma^\infty$ and a polynomial time computable martingale F , F succeeds on ξ if and only if there exists a martingale F' and a non-decreasing $O(n^2)$ -time computable (with respect to the unary representation of numbers) function from $h : N \rightarrow N$ such that $F'(\xi[0..n-1]) \geq h(n)$ for all n .

It is shown in [23] that p -random sequences are stochastic in the sense of von Mises and satisfy common statistical laws such as the law of the iterated logarithm. It is not difficult to show that all p -random sequences pass the NIST SP800-22 [17] tests for significance level 0.01 since each test in [17] could be converted to a polynomial time computable martingale which succeeds on all sequences that do not pass this test. However, none of the sequences generated by pseudorandom generators are p -random since from the generator algorithm itself, a martingale can be constructed to succeed on sequences that it generates.

Since there is no efficient mechanism to generate p -random sequences, pseudorandom generators are commonly used to produce long sequences for cryptographic applications. While the required uniformity property (see NIST SP800-22 [17]) for pseudorandom sequences is equivalent to the law of large numbers, the scalability property (see [17]) is equivalent to the invariance property under the operation of “admissible place selection” rules. Since p -random sequences satisfy common statistical laws, it is reasonable to expect that pseudorandom sequences produced by pseudorandom generators satisfy these laws also (see, e.g., [17]).

The law of the iterated logarithm (LIL) describes the fluctuation scales of a random walk. For a nonempty string

$x \in \Sigma^*$, let

$$S(x) = \sum_{i=0}^{|x|-1} x[i] \quad \text{and} \quad S^*(x) = \frac{2 \cdot S(x) - |x|}{\sqrt{|x|}}$$

where $S(x)$ denotes the *number* of 1s in x and $S^*(x)$ denotes the *reduced number* of 1s in x . $S^*(x)$ amounts to measuring the deviations of $S(x)$ from $\frac{|x|}{2}$ in units of $\frac{1}{2} \sqrt{|x|}$.

The law of large numbers says that, for a pseudo random sequence ξ , the limit of $\frac{S(\xi[0..n-1])}{n}$ is $\frac{1}{2}$, which corresponds to the frequency (Monobit) test in NIST SP800-22 [17]. But it says nothing about the reduced deviation $S^*(\xi[0..n-1])$. It is intuitively clear that, for a pseudorandom sequence ξ , $S^*(\xi[0..n-1])$ will sooner or later take on arbitrary large values (though slowly). The law of the iterated logarithm (LIL), which was first discovered by Khintchine [12], gives an optimal upper bound $\sqrt{2 \ln \ln n}$ for the fluctuations of $S^*(\xi[0..n-1])$. It was showed in Wang [23] that this law holds for p -random sequences also.

Theorem 3.3: (LIL for p -random sequences [23]) For a sequence $\xi \in \Sigma^\infty$, let

$$S_{lil}(\xi \upharpoonright n) = \frac{2 \sum_{i=0}^{n-1} \xi[i] - n}{\sqrt{2n \ln \ln n}} \quad (4)$$

Then for each p -random sequence $\xi \in \Sigma^\infty$ we have both

$$\limsup_{n \rightarrow \infty} S_{lil}(\xi \upharpoonright n) = 1 \quad \text{and} \quad \liminf_{n \rightarrow \infty} S_{lil}(\xi \upharpoonright n) = -1.$$

IV. NORMAL APPROXIMATIONS TO S_{lil}

In this section, we provide several results on normal approximations to the function $S_{lil}(\cdot)$ that will be used in next sections. The DeMoivre-Laplace theorem is a normal approximation to the binomial distribution, which says that the number of “successes” in n independent coin flips with head probability $1/2$ is approximately a normal distribution with mean $n/2$ and standard deviation $\sqrt{n}/2$. We first review a few classical results on the normal approximation to the binomial distribution.

Definition 4.1: The normal density function with mean μ and variance σ is defined as

$$f(x) = \frac{1}{\sigma \sqrt{2\pi}} e^{-\frac{(x-\mu)^2}{2\sigma^2}}; \quad (5)$$

For $\mu = 0$ and $\sigma = 1$, we have the standard normal density function

$$\varphi(x) = \frac{1}{\sqrt{2\pi}} e^{-\frac{x^2}{2}}, \quad (6)$$

its integral

$$\Phi(x) = \int_{-\infty}^x \varphi(y) dy \quad (7)$$

is the standard normal distribution function.

Lemma 4.2: ([7, Chapter VII.1, p175]) For every $x > 0$, we have

$$(x^{-1} - x^{-3})\varphi(x) < 1 - \Phi(x) < x^{-1}\varphi(x) \quad (8)$$

The following DeMoivre-Laplace limit theorem is derived from the approximation Theorem on page 181 of [7].

Theorem 4.3: For fixed x_1, x_2 , we have

$$\lim_{n \rightarrow \infty} \text{Prob} [x_1 \leq S^*(\xi \upharpoonright n) \leq x_2] = \Phi(x_2) - \Phi(x_1). \quad (9)$$

The growth speed for the above approximation is bounded by $\max\{k^2/n^2, k^4/n^3\}$ where $k = S(\xi \upharpoonright n) - \frac{n}{2}$.

The following lemma is useful for interpreting S^* based approximation results into S_{lil} based approximation. It is obtained by noting the fact that $\sqrt{2 \ln \ln n} \cdot S_{lil}(\xi \upharpoonright n) = S^*(\xi \upharpoonright n)$.

Lemma 4.4: For any x_1, x_2 , we have

$$\begin{aligned} \text{Prob} [x_1 < S_{lil}(\xi \upharpoonright n) < x_2] \\ = \text{Prob} [x_1 \sqrt{2 \ln \ln n} < S^*(\xi \upharpoonright n) < x_2 \sqrt{2 \ln \ln n}] \end{aligned}$$

In this paper, we only consider tests for $n \geq 2^{26}$ and $x_2 \leq 1$. That is, $S^*(\xi \upharpoonright n) \leq \sqrt{2 \ln \ln n}$. Thus

$$k = S(\xi \upharpoonright n) - \frac{n}{2} \simeq \frac{\sqrt{n}}{2} S^*(\xi \upharpoonright n) \leq \sqrt{2n \ln \ln n} / 2.$$

Hence, we have

$$\max \left\{ \frac{k^2}{n^2}, \frac{k^4}{n^3} \right\} = \frac{k^2}{n^2} = \frac{(1 - \alpha)^2 \ln \ln n}{2n} < 2^{-22}$$

By Theorem 4.3, the approximation probability calculation errors in this paper will be less than $0.0000002 < 2^{-22}$ which is negligible. Unless stated otherwise, we will not mention the approximation errors in the remainder of this paper.

V. WEAK-LIL TEST AND DESIGN

Theorem 3.3 shows that pseudorandom sequences should satisfy the law of the iterated logarithm (LIL). Thus we propose the following weak LIL test for random sequences.

Weak LIL Test: Let $\alpha \in (0, 0.25]$ and $\mathfrak{N} \subset N$ be a subset of natural numbers, we say that a sequence ξ does not pass the weak (α, \mathfrak{N}) -LIL test if $-1 + \alpha < S_{lil}(\xi \upharpoonright n) < 1 - \alpha$ for all $n \in \mathfrak{N}$. Furthermore, $\mathbf{P}_{(\alpha, \mathfrak{N})}$ denotes the probability that a random sequence passes the weak (α, \mathfrak{N}) -LIL test, and $\mathbf{E}_{(\alpha, \mathfrak{N})}$ is the set of sequences that pass the weak (α, \mathfrak{N}) -LIL test.

By the definition, a sequence ξ passes the weak (α, \mathfrak{N}) -LIL test if S_{lil} reaches either $1 - \alpha$ or $-1 + \alpha$ at some points in \mathfrak{N} . In practice, it is important to choose appropriate test point set \mathfrak{N} and calculate the probability for a random sequence ξ to pass the weak (α, \mathfrak{N}) -LIL test. In this section we calculate the probability for a sequence to pass the weak (α, \mathfrak{N}) -LIL test with the following choices of \mathfrak{N} :

$$\mathfrak{N}_0 = \{2^0 n_1\}, \dots, \mathfrak{N}_t = \{2^t n_1\}, \quad \text{and} \quad \bigcup \mathfrak{N}_i$$

for given n_1 and t . Specifically, we will consider the cases for $t = 8$ and $n_1 = 2^{26}$.

Theorem 5.1: Let $x_1, \dots, x_t \in \{0, 1\}^n$. Then we have

$$S_{lil}(x_1) + \dots + S_{lil}(x_t) = S_{lil}(x_1 \cdots x_t) \cdot \sqrt{\frac{t \ln \ln(tn)}{\ln \ln n}} \quad (10)$$

Proof. By (4), we have

$$\begin{aligned}
S_{lil}(x_1) + \dots + S_{lil}(x_t) &= \frac{2 \sum_{i=1}^t S(x_i) - tn}{\sqrt{2n \ln \ln n}} \\
&= \frac{2 \cdot S(x_1 \dots x_t) - tn}{\sqrt{2n \ln \ln n}} \\
&= \frac{2 \cdot S(x_1 \dots x_t) - tn}{\sqrt{2 \cdot tn \ln \ln tn}} \cdot \sqrt{\frac{t \ln \ln tn}{\ln \ln n}} \\
&= S_{lil}(x_1 \dots x_t) \cdot \sqrt{\frac{t \ln \ln tn}{\ln \ln n}}
\end{aligned} \tag{11}$$

□

Theorem 5.1 can be generalized as follows.

Theorem 5.2: Let $x_1 \in \{0, 1\}^{sn}$ and $x_2 \in \{0, 1\}^{tn}$. Then we have

$$\begin{aligned}
S_{lil}(x_1) \sqrt{s \ln \ln(sn)} + S_{lil}(x_2) \sqrt{t \ln \ln tn} \\
= S_{lil}(x_1 x_2) \sqrt{(s+t) \ln \ln(s+t)n}
\end{aligned} \tag{12}$$

Proof. We first note that

$$S_{lil}(x_1) \sqrt{s \ln \ln(sn)} = (2 \cdot S(x_1) - sn) / \sqrt{2n} \tag{13}$$

$$S_{lil}(x_2) \sqrt{t \ln \ln tn} = (2 \cdot S(x_2) - tn) / \sqrt{2n} \tag{14}$$

By adding equations (13) and (14) together, we get (12). The theorem is proved. □

Corollary 5.3: Let $0 < \theta < 1$ and $1 \leq s < t$. For given $\xi \uparrow sn$ with $S_{lil}(\xi \uparrow sn) = \varepsilon$ and randomly chosen $\xi \uparrow [sn..tn - 1]$,

$$\begin{aligned}
\text{Prob}[S_{lil}(\xi \uparrow tn) \geq \theta] &= \\
\text{Prob}\left[S^*(\xi \uparrow [sn..tn - 1]) \geq \sqrt{\frac{2}{t-s}} (\theta \sqrt{t \ln \ln tn} - \varepsilon \sqrt{s \ln \ln sn})\right]
\end{aligned} \tag{15}$$

Proof. By Theorem 5.2, we have

$$\begin{aligned}
S_{lil}(\xi \uparrow [0..tn - 1]) \sqrt{t \ln \ln tn} = \\
S_{lil}(\xi \uparrow [sn..tn - 1]) \sqrt{(t-s) \ln \ln(t-s)n} + \varepsilon \sqrt{s \ln \ln sn}.
\end{aligned} \tag{16}$$

Thus $S_{lil}(\xi \uparrow [0..tn - 1]) \geq \theta$ if, and only if,

$$S_{lil}(\xi \uparrow [sn..tn - 1]) \geq \frac{\theta \sqrt{t \ln \ln tn} - \varepsilon \sqrt{s \ln \ln sn}}{\sqrt{(t-s) \ln \ln(t-s)n}} \tag{17}$$

By Lemma 4.4, (17) is equivalent to (18).

$$S^*(\xi \uparrow [sn..tn - 1]) \geq \sqrt{\frac{2}{t-s}} (\theta \sqrt{t \ln \ln tn} - \varepsilon \sqrt{s \ln \ln sn}) \tag{18}$$

In other words, (15) holds. □

After these preliminary results, we will begin to calculate the probability for a random sequence to pass the weak (α, \mathfrak{N}) -LIL test.

Example 5.4: For $\alpha = 0.1$, $\alpha = 0.05$, and $\mathfrak{N}_i = \{2^{i+26}\}$ with $0 \leq i \leq 8$, the entry at $(\mathfrak{N}_i, \mathfrak{N}_i)$ in Table I list the probability $\mathbf{P}_{(\alpha, \mathfrak{N})}$ that a random sequence passes the weak (α, \mathfrak{N}_i) -LIL test. *Proof.* Let $\theta = 1 - \alpha$. By Theorem 4.3 and Lemma 4.4,

$$\text{Prob}[|S_{lil}(\xi \uparrow n)| \geq \theta] \simeq 2(1 - \Phi(\theta \sqrt{2 \ln \ln n})). \tag{19}$$

By substituting $\theta = 0.95$ (respectively 0.9), and $n = 2^{26}, \dots, n = 2^{34}$ into (19), we obtain the value $\mathbf{P}_{(0.1, \mathfrak{N}_i)}$ (respectively $\mathbf{P}_{(0.05, \mathfrak{N}_i)}$) at the entry $(\mathfrak{N}_i, \mathfrak{N}_i)$ in Table I. This completes the proof of the Theorem. □

Now we consider the probability for a random sequence to pass the weak (α, \mathfrak{N}) -LIL test with \mathfrak{N} as the union of two \mathfrak{N}_i . First we present the following union theorem.

Theorem 5.5: For fixed $0 < \alpha < 1$ and $t \geq 2$, let $\theta = 1 - \alpha$, $\mathfrak{N} = \{n, tn\}$, $\mathfrak{N}_a = \{n\}$, $\mathfrak{N}_b = \{tn\}$. We have

$$\begin{aligned}
\mathbf{P}_{(\alpha, \mathfrak{N})} &\simeq \mathbf{P}_{(\alpha, \mathfrak{N}_a)} + \\
&\frac{1}{\pi} \int_{-\theta \sqrt{2 \ln \ln n}}^{\theta \sqrt{2 \ln \ln n}} \int_{\sqrt{\frac{1}{t-1}} (\theta \sqrt{2t \ln \ln tn} - y)}^{\infty} e^{-\frac{x^2+y^2}{2}} dx dy
\end{aligned} \tag{20}$$

Alternatively, we have

$$\begin{aligned}
\mathbf{P}_{(\alpha, \mathfrak{N})} &\simeq \mathbf{P}_{(\alpha, \mathfrak{N}_a)} + \mathbf{P}_{(\alpha, \mathfrak{N}_b)} - \\
&\frac{1}{\pi} \int_{\theta \sqrt{2 \ln \ln n}}^{\infty} \int_{\sqrt{\frac{1}{t-1}} (\theta \sqrt{2t \ln \ln tn} - y)}^{\infty} e^{-\frac{x^2+y^2}{2}} dx dy
\end{aligned} \tag{21}$$

Proof. Since $\mathbf{E}_{(\alpha, \mathfrak{N})} = \mathbf{E}_{(\alpha, \mathfrak{N}_a)} \cup \mathbf{E}_{(\alpha, \mathfrak{N}_b)}$, we have

$$\mathbf{P}_{(\alpha, \mathfrak{N})} = (\mathbf{P}_{(\alpha, \mathfrak{N}_a)} + \mathbf{P}_{(\alpha, \mathfrak{N}_b)}) - \mathbf{P}_{(\alpha, \mathfrak{N}_a \cap \mathfrak{N}_b)}$$

where

$$\mathbf{E}_{(\alpha, \mathfrak{N}_a \cap \mathfrak{N}_b)} = \left\{ \xi : |S_{lil}(\xi \uparrow n)| > \theta \sqrt{|S_{lil}(\xi \uparrow tn)|} > \theta \right\}.$$

By symmetry, it suffices to show that

$$\begin{aligned}
\text{Prob}[S_{lil}(\xi \uparrow tn) \geq \theta | \mathbf{E}_{(\alpha, \mathfrak{N}_a)}] \\
\simeq \frac{1}{2\pi} \int_{-\theta \sqrt{2 \ln \ln n}}^{\theta \sqrt{2 \ln \ln n}} \int_{\sqrt{\frac{1}{t-1}} (\theta \sqrt{2t \ln \ln tn} - y)}^{\infty} e^{-\frac{x^2+y^2}{2}} dx dy
\end{aligned} \tag{22}$$

Let $\Delta_1 = \sqrt{2 \ln \ln n} \cdot \Delta z$. By Corollary 5.3, the probability that $S_{lil}(\xi \uparrow n) \in [z, z + \Delta z]$ and $S_{lil}(\xi \uparrow tn) > \theta$ is approximately

$$\begin{aligned}
\int_z^{\sqrt{2 \ln \ln n} + \Delta_1} \int_{\sqrt{\frac{2}{t-1}} (\theta \sqrt{t \ln \ln tn} - z \sqrt{\ln \ln n})}^{\infty} \varphi(x) dx \\
\int_{\sqrt{\frac{2}{t-1}} (\theta \sqrt{t \ln \ln tn} - z \sqrt{\ln \ln n})}^{\infty} \varphi(x) dx \\
\simeq \Delta_1 \cdot \varphi(z \sqrt{2 \ln \ln n}) \cdot \int_{\sqrt{\frac{2}{t-1}} (\theta \sqrt{t \ln \ln tn} - z \sqrt{\ln \ln n})}^{\infty} \varphi(x) dx
\end{aligned} \tag{23}$$

By substituting $y = z \sqrt{2 \ln \ln n}$ and integrating the equation (23) over the interval $y \in [-\theta \sqrt{2 \ln \ln n}, \theta \sqrt{2 \ln \ln n}]$, we get the equation (22).

The equation (21) could be proved similarly by the following observation: a sequence passes the weak (α, \mathfrak{N}) -LIL test if it passes the weak LIL test at point n or at point $2n$. Thus the total probability is the sum of these two probabilities minus the probability that the sequence passes the weak LIL test at both points at the same time. The theorem is then proved. □

Example 5.6: For $\alpha = 0.1$ (respectively $\alpha = 0.05$) and $\mathfrak{N}_i = \{2^{i+26}\}$ with $0 \leq i < j \leq 8$, the entry at $(\mathfrak{N}_i, \mathfrak{N}_j)$ in Table I is the probability that a random sequence passes the weak $(0.1, \mathfrak{N}_i \cup \mathfrak{N}_j)$ -LIL test (respectively, $(0.05, \mathfrak{N}_i \cup \mathfrak{N}_{i+1})$ -LIL test).

Proof. The probability could be calculated using either equation (20) or (21) in Theorem 5.5 with $\theta = 1 - \alpha$. Our analysis shows that results from (20) and (21) have a difference

TABLE I
WEAK (0.1, \aleph)-LIL AND (0.05, \aleph)-LIL TEST PROBABILITIES

α	\aleph_0	\aleph_1	\aleph_2	\aleph_3	\aleph_4	\aleph_5	\aleph_6	\aleph_7	\aleph_8
$\alpha = 0.1$									
\aleph_0	0.03044	0.05085	0.05441	0.05540	0.05544	0.05507	0.05453	0.05394	0.05334
\aleph_1		0.02938	0.04918	0.05263	0.05361	0.05365	0.05331	0.05281	0.05226
\aleph_2			0.02838	0.04762	0.05097	0.05193	0.05199	0.05168	0.05121
\aleph_3				0.02746	0.04616	0.04942	0.05036	0.05043	0.05014
\aleph_4					0.02661	0.04479	0.04797	0.04888	0.04897
\aleph_5						0.02580	0.04351	0.04660	0.04750
\aleph_6							0.02505	0.04230	0.04531
\aleph_7								0.02434	0.04116
\aleph_8									0.02367
$\alpha = 0.05$									
\aleph_0	0.02234	0.03770	0.04016	0.04074	0.04065	0.04029	0.03983	0.03935	0.03886
\aleph_1		0.02148	0.03633	0.03871	0.03928	0.03921	0.03888	0.03845	0.03799
\aleph_2			0.02068	0.03506	0.03737	0.03792	0.03786	0.03756	0.03716
\aleph_3				0.01995	0.03387	0.03611	0.03666	0.03661	0.03632
\aleph_4					0.01926	0.03277	0.03494	0.03547	0.03544
\aleph_5						0.01862	0.03173	0.03384	0.03437
\aleph_6							0.01802	0.03076	0.03281
\aleph_7								0.01746	0.02985
\aleph_8									0.01693

smaller than 0.00000001 which is negligible. The values in Table I are computed using the equation (20) and then verified using the equation (21). \square

VI. WEAK-LIL TEST DESIGN II

In this section, we consider the design of weak (α, \aleph) -LIL test with \aleph consisting at least three points. To be consistent with Section V, we use the following notations: $\aleph_0 = \{2^0 n_1\}, \dots$, and $\aleph_t = \{2^t n_1\}$ for given n_1 and t . In particular, we will consider the cases for $n_1 = 2^{26}$.

Theorem 6.1: For fixed $0 < \alpha < 1$ and $t_1, t_2 \geq 2$, let $\theta = 1 - \alpha$, $\aleph = \{n, t_1 n, t_1 t_2 n\}$, and $\aleph_a = \{n, t_1 n\}$. Then we have

$$\mathbf{P}_{(\alpha, \aleph)} \simeq \frac{\mathbf{P}_{(\alpha, \aleph_a)} + 1}{2\pi \sqrt{2\pi(t_1 - 1)}} \int_{C_1} \int_{C_2} \int_{C_3} e^{-\frac{x^2+y^2}{2} - \frac{(z-y)^2}{2(t_1-1)}} dx dy dz \quad (24)$$

where

$$\begin{aligned} C_1 &= [-\theta \sqrt{2t_1 \ln \ln t_1 n}, \theta \sqrt{2t_1 \ln \ln t_1 n}] \\ C_2 &= [-\theta \sqrt{2 \ln \ln n}, \theta \sqrt{2 \ln \ln n}] \\ C_3 &= \left[\sqrt{\frac{1}{t_2 - 1}} (\theta \sqrt{2t_2 \ln \ln t_2 t_1 n} - z / \sqrt{t_1}), \infty \right). \end{aligned}$$

Proof. By symmetry, it suffices to show that

$$\begin{aligned} & \text{Prob} [S_{lil}(\xi \uparrow t_1 t_2 n) \geq \theta \overline{\mathbf{E}}_{\alpha, \aleph_a}] \\ & \simeq \frac{1}{2\pi \sqrt{2\pi(t_1 - 1)}} \int_{C_1} \int_{C_2} \int_{C_3} e^{-\frac{x^2+y^2}{2} - \frac{(z-y)^2}{2(t_1-1)}} dx dy dz \end{aligned} \quad (25)$$

By Corollary 5.3, the probability that $S_{lil}(\xi \uparrow t_1 n) \in [z, z + \Delta z]$ and $S_{lil}(\xi \uparrow t_1 t_2 n) > \theta$ is approximately

$$P_{(z, \Delta z, t_1 n)} \cdot \int_{\sqrt{\frac{2}{t_2-1}} (\theta \sqrt{2t_2 \ln \ln t_2 t_1 n} - z \sqrt{\ln \ln t_1 n})}^{\infty} \varphi(x) dx \quad (26)$$

where $P_{(z, \Delta z, t_1 n)}$ is the probability that $S_{lil}(\xi \uparrow t_1 n) \in [z, z + \Delta z]$. Let $\Delta_1 = \sqrt{2t_1 \ln \ln t_1 n} \cdot \Delta z$. By equation (22) in the proof of Theorem 5.5, the probability $P_{(z, \Delta z, t_1 n)}$ under the conditional event “ $|S_{lil}(\xi \uparrow n)| < \theta$ ” is approximately

$$\begin{aligned} P_{(z, \Delta z, t_1 n)} & \simeq \\ & \frac{1}{2\pi} \int_{C_2} \int_{\frac{z \sqrt{2t_1 \ln \ln t_1 n} + \Delta_1 - y}}^{\frac{z \sqrt{2t_1 \ln \ln t_1 n} + \Delta_1 - y}} \frac{e^{-\frac{x^2+y^2}{2}}}{\sqrt{t_1-1}} dx dy \\ & \simeq \int_{C_2} \varphi(y) \varphi\left(\frac{z \sqrt{2t_1 \ln \ln t_1 n} - y}{\sqrt{t_1-1}}\right) \frac{\Delta_1}{\sqrt{t_1-1}} dy \\ & \simeq \frac{\Delta_1}{\sqrt{t_1-1}} \int_{C_2} \varphi(y) \cdot \varphi\left(\frac{z \sqrt{2t_1 \ln \ln t_1 n} - y}{\sqrt{t_1-1}}\right) dy \end{aligned} \quad (27)$$

By substituting (27) into (26), replacing $z \sqrt{2t_1 \ln \ln t_1 n}$ with w , and integrating the obtained equation (27) over the interval $w \in [-\theta \sqrt{2t_1 \ln \ln t_1 n}, \theta \sqrt{2t_1 \ln \ln t_1 n}]$, and finally replacing the variable w back to z , equation (25) is obtained. The theorem is then proved. \square

Example 6.2: Let $n_1 = 2^{26}$. By equation (24) in Theorem 6.1, we can calculate the following probabilities:

- 1) $\mathbf{P}_{(0.1, \aleph_0 \cup \aleph_3 \cup \aleph_6)} = 0.07755$;
- 2) $\mathbf{P}_{(0.1, \aleph_0 \cup \aleph_3 \cup \aleph_8)} = 0.07741$;
- 3) $\mathbf{P}_{(0.1, \aleph_0 \cup \aleph_6 \cup \aleph_8)} = 0.07417$;
- 4) $\mathbf{P}_{(0.1, \aleph_3 \cup \aleph_6 \cup \aleph_8)} = 0.06995$;
- 5) $\mathbf{P}_{(0.05, \aleph_0 \cup \aleph_4 \cup \aleph_8)} = 0.05645$;

By trying all different combinations, it can be shown that for any $\aleph = \aleph_{i_1} \cup \aleph_{i_2} \cup \aleph_{i_3}$ with different $0 \leq i_1, i_2, i_3 \leq 8$, we have $0.069 \leq \mathbf{P}_{0.1, \aleph} \leq 0.08$ and $0.05 \leq \mathbf{P}_{0.05, \aleph} \leq 0.06$.

Theorem 6.1 provides an algorithm for computing the probability $\mathbf{P}_{\alpha, \aleph}$ when \aleph contains three points. By recursively applying Corollary 5.3 as in the proof of Theorem 6.1, we can obtain algorithms for calculating the probability $\mathbf{P}_{\alpha, \aleph}$ when \aleph contains more than three points. The process is straightforward.

ward though tedious and the details are omitted here. In the following, we give an alternative approach to approximate the probability $\mathbf{P}_{(\alpha, \mathfrak{N})}$ with $|\mathfrak{N}| > 3$ by using Theorems 5.5 and 6.1.

We show the approximation technique with the example of $\alpha = 0.1$ and $\mathfrak{N} = \mathfrak{N}_0 \cup \mathfrak{N}_3 \cup \mathfrak{N}_6 \cup \mathfrak{N}_8$. First we note that

$$\mathbf{P}_{(\alpha, \mathfrak{N})} = \mathbf{P}_{(\alpha, \mathfrak{N}_0 \cup \mathfrak{N}_3 \cup \mathfrak{N}_6)} + \mathbf{P}_{(\alpha, \mathfrak{N}_8)} - \text{Prob}[\mathbf{E}_{(\alpha, \mathfrak{N}_8)} \cap \mathbf{E}_{(\alpha, \mathfrak{N}_0 \cup \mathfrak{N}_3 \cup \mathfrak{N}_6)}] \quad (28)$$

Since

$$\mathbf{E}_{(\alpha, \mathfrak{N}_8)} \cap \mathbf{E}_{(\alpha, \mathfrak{N}_0 \cup \mathfrak{N}_3 \cup \mathfrak{N}_6)} = (\mathbf{E}_{(\alpha, \mathfrak{N}_8)} \cap \mathbf{E}_{(\alpha, \mathfrak{N}_0)}) \cup (\mathbf{E}_{(\alpha, \mathfrak{N}_8)} \cap \mathbf{E}_{(\alpha, \mathfrak{N}_3)}) \cup (\mathbf{E}_{(\alpha, \mathfrak{N}_8)} \cap \mathbf{E}_{(\alpha, \mathfrak{N}_6)})$$

we have

$$\begin{aligned} & \text{Prob}[\mathbf{E}_{(\alpha, \mathfrak{N}_8)} \cap \mathbf{E}_{(\alpha, \mathfrak{N}_0 \cup \mathfrak{N}_3 \cup \mathfrak{N}_6)}] \\ &= \text{Prob}[\mathbf{E}_{(\alpha, \mathfrak{N}_0)} \cap \mathbf{E}_{(\alpha, \mathfrak{N}_8)}] + \text{Prob}[\mathbf{E}_{(\alpha, \mathfrak{N}_3)} \cap \mathbf{E}_{(\alpha, \mathfrak{N}_8)}] \\ & \quad + \text{Prob}[\mathbf{E}_{(\alpha, \mathfrak{N}_6)} \cap \mathbf{E}_{(\alpha, \mathfrak{N}_8)}] \\ & \quad - \text{Prob}[\mathbf{E}_{(\alpha, \mathfrak{N}_0)} \cap \mathbf{E}_{(\alpha, \mathfrak{N}_3)} \cap \mathbf{E}_{(\alpha, \mathfrak{N}_8)}] \\ & \quad - \text{Prob}[\mathbf{E}_{(\alpha, \mathfrak{N}_0)} \cap \mathbf{E}_{(\alpha, \mathfrak{N}_6)} \cap \mathbf{E}_{(\alpha, \mathfrak{N}_8)}] \\ & \quad - \text{Prob}[\mathbf{E}_{(\alpha, \mathfrak{N}_3)} \cap \mathbf{E}_{(\alpha, \mathfrak{N}_6)} \cap \mathbf{E}_{(\alpha, \mathfrak{N}_8)}] \\ & \quad + 2 \cdot \text{Prob}[\mathbf{E}_{(\alpha, \mathfrak{N}_0)} \cap \mathbf{E}_{(\alpha, \mathfrak{N}_3)} \cap \mathbf{E}_{(\alpha, \mathfrak{N}_6)} \cap \mathbf{E}_{(\alpha, \mathfrak{N}_8)}] \end{aligned} \quad (29)$$

Let $\varepsilon = \text{Prob}[\mathbf{E}_{(\alpha, \mathfrak{N}_0)} \cap \mathbf{E}_{(\alpha, \mathfrak{N}_3)} \cap \mathbf{E}_{(\alpha, \mathfrak{N}_6)} \cap \mathbf{E}_{(\alpha, \mathfrak{N}_8)}]$. By substituting (29) into (28) and simplifying it, we get

$$\begin{aligned} \mathbf{P}_{(\alpha, \mathfrak{N})} &= \sum_{i \in \{0, 3, 6, 8\}} \mathbf{P}_{(\alpha, \mathfrak{N}_i)} \\ & \quad + \sum_{i_1, i_2, i_3 \in \{0, 3, 6, 8\}} \mathbf{P}_{(\alpha, \mathfrak{N}_{i_1} \cup \mathfrak{N}_{i_2} \cup \mathfrak{N}_{i_3})} \\ & \quad - \sum_{i_1, i_2 \in \{0, 3, 6, 8\}} \mathbf{P}_{(\alpha, \mathfrak{N}_{i_1} \cup \mathfrak{N}_{i_2})} - 2\varepsilon \\ &\approx 0.09662 - 2\varepsilon \end{aligned} \quad (30)$$

On the other hand, we have

$$\begin{aligned} 2\varepsilon &< 2 \cdot \text{Prob}[\mathbf{E}_{(\alpha, \mathfrak{N}_3)} \cap \mathbf{E}_{(\alpha, \mathfrak{N}_6)} \cap \mathbf{E}_{(\alpha, \mathfrak{N}_8)}] \\ &= \mathbf{P}_{(\alpha, \mathfrak{N}_3 \cup \mathfrak{N}_6 \cup \mathfrak{N}_8)} + \sum_{i \in \{3, 6, 8\}} \mathbf{P}_{(\alpha, \mathfrak{N}_i)} \\ & \quad - \sum_{i_1, i_2 \in \{3, 6, 8\}} \mathbf{P}_{(\alpha, \mathfrak{N}_{i_1} \cup \mathfrak{N}_{i_2})} \\ &\approx 0.00032 \end{aligned}$$

Thus we have $0.09630 < \mathbf{P}_{(\alpha, \mathfrak{N})} < 0.09662$. In other words, a random sequence passes the weak $(0.1, \mathfrak{N}_0 \cup \mathfrak{N}_3 \cup \mathfrak{N}_6 \cup \mathfrak{N}_8)$ -LIL test with approximately 9.65% probability.

VII. STRONG LIL TEST DESIGN

This section considers the following strong LIL tests.

Strong LIL Test: Let $\alpha \in (0, 0.25]$ and $\mathfrak{N}_a, \mathfrak{N}_b, \mathfrak{N}_c \subset N$ be subsets of natural numbers. We say that a sequence ξ passes the strong $(\alpha; \mathfrak{N}_a, \mathfrak{N}_b)$ -LIL test if there exist $n_1 \in \mathfrak{N}_a$ and $n_2 \in \mathfrak{N}_b$ such that

$$\begin{aligned} |S_{lil}(\xi \upharpoonright n_i)| &> 1 - \alpha \text{ for } i = 1, 2; \\ S_{lil}(\xi \upharpoonright n_1)S_{lil}(\xi \upharpoonright n_2) &< 0. \end{aligned} \quad (31)$$

Alternatively, we say that a sequence ξ passes the strong $(\alpha; \mathfrak{N}_c)$ -LIL test if there exist $n_1, n_2 \in \mathfrak{N}_c$ such that (31) holds. Furthermore, $\mathbf{SP}_{(\alpha; \mathfrak{N}_a, \mathfrak{N}_b)}$ and $\mathbf{SP}_{(\alpha; \mathfrak{N}_c)}$ denote the probability

that a random sequence passes the strong $(\alpha; \mathfrak{N}_a, \mathfrak{N}_b)$ -LIL and $(\alpha; \mathfrak{N}_c)$ -LIL tests respectively.

Theorem 7.1: For fixed $0 < \alpha < 1$ and $t \geq 2$, let $\theta = 1 - \alpha$, $\mathfrak{N}_a = \{n\}$, and $\mathfrak{N}_b = \{tn\}$. We have

$$\mathbf{SP}_{(\alpha; \mathfrak{N}_a, \mathfrak{N}_b)} \approx \frac{1}{\pi} \int_{\theta \sqrt{2 \ln \ln n}}^{\infty} \int_{-\infty}^{-\sqrt{\frac{1}{t-1}}(\theta \sqrt{2t \ln \ln m+y})} e^{-\frac{t+y^2}{2}} dx dy \quad (32)$$

Proof. The theorem could be proved in a similar way as in the proof of Theorem 5.5. \square

Example 7.2: Let $\alpha = 0.1$, $\mathfrak{N}_0 = \{2^{26}\}$, $\mathfrak{N}_7 = \{2^{33}\}$, and $\mathfrak{N}_8 = \{2^{34}\}$. Then we have $\mathbf{SP}_{(\alpha, \mathfrak{N}_0, \mathfrak{N}_7)} \approx 0.0001981$ and $\mathbf{SP}_{(\alpha, \mathfrak{N}_0, \mathfrak{N}_8)} \approx 0.0002335$

In the following, we provide another approach for obtaining better probability bounds for strong LIL tests. In a negative binomial distribution $f(k; r, \frac{1}{2})$ denote the probability that the r th one appears at the position $r+k$. It is well known that for this distribution, we have mean $\mu = r$ and variance $\sigma = \sqrt{2r}$. Thus the probability that the r 's one appears before the n th position is approximated by the following probability:

$$\frac{1}{2\sqrt{r\pi}} \int_{-\infty}^n e^{-\frac{(x-2r)^2}{4r}} dx \quad (33)$$

For $n_1 = 2^{26}$ and $n_2 = 2^{34}$, assume that $S_{lil}(\xi \upharpoonright n_1) \leq -y$ for given $y \geq \theta$. Then we have

$$S(\xi \upharpoonright n_1) \leq \frac{n_1 - y \sqrt{2n_1 \ln \ln n_1}}{2} \quad (34)$$

By (34), in order for $S_{lil}(\xi \upharpoonright n_2) \geq \theta$, we need to have

$$\begin{aligned} r(y) = S(\xi \upharpoonright n_1 \dots n_2 - 1) \\ \geq \frac{n_2 + \theta \sqrt{2n_2 \ln \ln n_2} - n_1 + y \sqrt{2n_1 \ln \ln n_1}}{2} \end{aligned} \quad (35)$$

Let $\alpha = 1 - \theta$, $\mathfrak{N}_a = \{n_1\}$, and $\mathfrak{N}_b = \{n_2\}$. Using the same argument as in the proof of Theorem 5.5 (in particular, the arguments for integrating equation (23)) and the negative binomial distribution equation (33), the probability that a sequence passes the strong $(\alpha; \mathfrak{N}_a, \mathfrak{N}_b)$ -LIL test can be calculated with the following equation.

$$\frac{1}{\pi} \int_{-\infty}^{-\theta \sqrt{2 \ln \ln n_1}} \int_{-\infty}^{n_2 - n_1} \frac{1}{\sqrt{2r(y)}} e^{-\frac{y^2}{2} - \frac{(x-2r(y))^2}{4r(y)}} dx dy \quad (36)$$

By substituting the values of θ , n_1 , and n_2 , (36) evaluates to 0.0002335. In other words, a random sequence passes the strong $(0.1; \mathfrak{N}_0, \mathfrak{N}_8)$ -LIL test with probability 0.023% (this value is same as the value in Example 7.2).

Both (32) and (36) could be used to calculate the probability for strong LIL tests. These equations could be used to generalize results in Example 7.2 to cases of strong $(\alpha; \mathfrak{N}_a, \mathfrak{N}_b)$ -LIL test with multiple points in \mathfrak{N}_b .

VIII. EVALUATING PSEUDORANDOM GENERATORS

In order to evaluate the quality of a pseudorandom generator \mathcal{G} , we first choose a fixed n of sequence length, a value $0 < \alpha \leq 0.1$, and mutually distinct subsets $\mathfrak{N}_0, \dots, \mathfrak{N}_t$ of

$\{1, \dots, n\}$. It is preferred that the S_{lil} values on these subsets are as independent as possible (though they are impossible to be independent). For example, we may choose \mathfrak{N}_i as in Section VI. Then we can carry out the following steps.

- 1) Set $\mathbf{P}_{(\alpha, \mathfrak{N})}^+ = \mathbf{P}_{(\alpha, \mathfrak{N})}^- = \frac{1}{2} \mathbf{P}_{(\alpha, \mathfrak{N})}$ for all \mathfrak{N} .
- 2) Use \mathcal{G} to construct a set of $m \geq 100$ binary sequences of length n .
- 3) For each \mathfrak{N} , calculate probability $P_{(\alpha, \mathfrak{N})}^+$ that these sequences pass the weak (α, \mathfrak{N}_i) -LIL test via $S_{lil} \geq 1 - \alpha$ (respectively, $P_{(\alpha, \mathfrak{N})}^-$ for $S_{lil} \leq -1 + \alpha$).
- 4) Calculate the average absolute probability distance

$$\Delta_{wlll} = \frac{1}{t+1} \sum_{i=0}^t \mathbf{P}_{(\alpha, \mathfrak{N}_i)}^{-1} \left(\left| P_{(\alpha, \mathfrak{N}_i)}^+ - \mathbf{P}_{(\alpha, \mathfrak{N}_i)}^+ \right| + \left| P_{(\alpha, \mathfrak{N}_i)}^- - \mathbf{P}_{(\alpha, \mathfrak{N}_i)}^- \right| \right)$$

and the root-mean-square deviation

$$\text{RMSD}_{wlll} = \sqrt{\frac{\sum_{0 \leq i \leq j \leq t} (p_{i,j,1}^2 + p_{i,j,2}^2)}{(t+1)(t+2)}}$$

where $p_{i,j,1}^+ = P_{(\alpha, \mathfrak{N}_i \cup \mathfrak{N}_j)}^+ - \mathbf{P}_{(\alpha, \mathfrak{N}_i \cup \mathfrak{N}_j)}^+$ and $p_{i,j,2}^+ = P_{(\alpha, \mathfrak{N}_i \cup \mathfrak{N}_j)}^- - \mathbf{P}_{(\alpha, \mathfrak{N}_i \cup \mathfrak{N}_j)}^-$

- 5) Decision criteria: the smaller Δ_{wlll} and RMSD_{wlll} , the better generator \mathcal{G} .

IX. SNAPSHOT LIL TESTS AND RANDOM GENERATOR EVALUATION

We have considered statistical tests based on the limit theorem of the law of the iterated logarithm. These tests do not take full advantage of the distribution S_{lil} , which defines a probability measure on the real line R . Let $\mathcal{R} \subset \Sigma^n$ be a set of m sequences with a standard probability definition on it. That is, for each $x_0 \in \mathcal{R}$, let $\text{Prob}[x = x_0] = \frac{1}{m}$. Then each set $\mathcal{R} \subset \Sigma^n$ induces a probability measure $\mu_n^{\mathcal{R}}$ on R by letting

$$\mu_n^{\mathcal{R}}(I) = \text{Prob}[S_{lil}(x) \in I, x \in \mathcal{R}]$$

for each Lebesgue measurable set I on R . For $U = \Sigma^n$, we use μ_n^U to denote the corresponding probability measure induced by the uniform distribution. By Definition 2.2, if \mathcal{R}_n is the collection of all length n sequences generated by a pseudorandom generator, then the difference between μ_n^U and $\mu_n^{\mathcal{R}_n}$ is negligible.

By Theorem 4.3 and Lemma 4.4, for a uniformly chosen ξ , the distribution of $S^*(\xi \} n)$ could be approximated by a normal distribution of mean 0 and variance 1, with error bounded by $\frac{1}{n}$ (see [7]). In other words, the measure μ_n^U can be calculated as

$$\begin{aligned} \mu_n^U((-\infty, x]) &\simeq \Phi(x \sqrt{2 \ln \ln n}) \\ &= \sqrt{2 \ln \ln n} \int_{-\infty}^x \phi(y \sqrt{2 \ln \ln n}) dy. \end{aligned} \quad (37)$$

Table V in the Appendix lists values $\mu_n^U(I)$ for 0.05-length intervals I with $n = 2^{26}, \dots, 2^{34}$.

In order to evaluate a pseudorandom generator G , first choose a sequence of testing points n_0, \dots, n_t (e.g., $n_0 = 2^{26+t}$). Secondly use G to generate a set $\mathcal{R} \subseteq \Sigma^{n_t}$ of m sequences.

Lastly compare the distances between the two probability measures $\mu_n^{\mathcal{R}}$ and μ_n^U for $n = n_0, \dots, n_t$.

A generator G is considered ‘‘good’’, if for sufficiently large m , the distances between $\mu_n^{\mathcal{R}}$ and μ_n^U are negligible (or smaller than a given threshold). There are various definitions of statistical distances for probability measures. In our analysis, we will consider the total variation distance [4]

$$d(\mu_n^{\mathcal{R}}, \mu_n^U) = \sup_{A \subseteq \mathcal{B}} \left| \mu_n^{\mathcal{R}}(A) - \mu_n^U(A) \right| \quad (38)$$

Hellinger distance [11]

$$H(\mu_n^{\mathcal{R}} \parallel \mu_n^U) = \frac{1}{\sqrt{2}} \sqrt{\sum_{A \in \mathcal{B}} \left(\sqrt{\mu_n^{\mathcal{R}}(A)} - \sqrt{\mu_n^U(A)} \right)^2} \quad (39)$$

and the root-mean-square deviation

$$\text{RMSD}(\mu_n^{\mathcal{R}}, \mu_n^U) = \sqrt{\frac{\sum_{A \in \mathcal{B}} \left(\mu_n^{\mathcal{R}}(A) - \mu_n^U(A) \right)^2}{42}} \quad (40)$$

where \mathcal{B} is a partition of the real line R that is defined as

$$\{(\infty, 1), [1, \infty)\} \cup \{[0.05x - 1, 0.05x - 0.95] : 0 \leq x \leq 39\}.$$

In Section X, we will present some examples of using these distance to evaluate several pseudorandom generators.

X. EXPERIMENTAL RESULTS

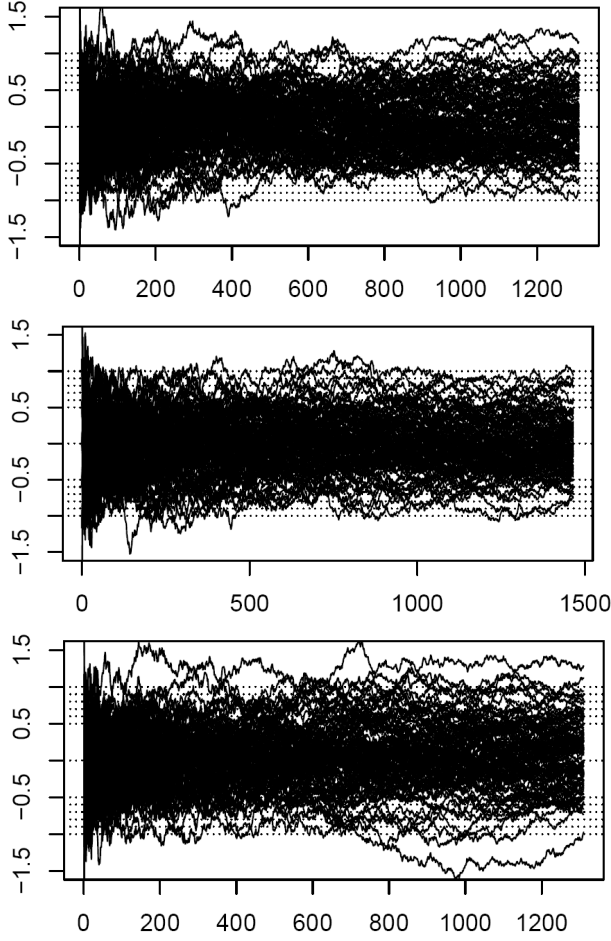
As an example to illustrate the importance of LIL tests, we carry out weak LIL test experiments on pseudorandom generators SHA1PRNG (Java) and NIST DRBG [17] with parameters $\alpha = 0.1$ (and 0.05) and $\mathfrak{N}_0 = \{2^{26}\}, \dots, \mathfrak{N}_8 = \{2^{34}\}$ (note that $2^{26}\text{bits} = 8\text{MB}$ and $2^{34}\text{bits} = 2\text{GB}$).

Before carrying out LIL based tests, we run NIST SP800-22 test tool [15] on sequences that have been generated. The test tool [15] only checks the first 1,215,752,192 bits ($\approx 145\text{MB}$) of a sequences since the software uses 4-byte `int` data type for integer variables. The initial 145MB of each sequence that we have generated passes NIST tests with P-values larger than 0.01 except for the ‘‘longest run of ones in a block’’ test which failed for several sequences.

A. Java SHA1PRNG API based sequences

The pseudorandom generator SHA1PRNG API in Java generates sequences $\text{SHA1}'(s, 0)\text{SHA1}'(s, 1)\dots$, where s is an optional seeding string of arbitrary length, the counter i is 64 bits long, and $\text{SHA1}'(s, i)$ is the first 64 bits of $\text{SHA1}(s, i)$. In the experiment, we generated one thousand of sequences with four-byte seeds of integers $0, 1, 2, \dots, 999$ respectively. For each sequence generation, the ‘‘`random.nextBytes()`’’ method of `SecureRandom` Class is called 2^{26} times and a 32-byte output is requested for each call. This produces sequences of 2^{34} bits long. The LIL test is then run on these sequences and the first picture in Figure 1 shows the LIL-test result curves for the first 100 sequences. To reduce the size of the figure, we use the scale $10000n^2$ for the x -axis. In other words, Figure 1 shows the values $S_{lil}(\xi[0..10000n^2 - 1])$ for $1 \leq n \leq 1310$. At this scale, the points $\mathfrak{N}_0, \dots, \mathfrak{N}_8$ are mapped to 82, 116, 164,

Fig. 1. LIL test results for sequences generated by Java SHA1PRNG, NIST SP800 90A SHA1-DRBG, and NIST SP800 90A SHA2-DRBG



232, 328, 463, 655, 927, and 1310 respectively. Table II shows the number of sequences that reach the value 0.9, -0.9, 0.95, and -0.95 at corresponding testing points respectively.

Using the partition set \mathcal{B} , the probability distributions $\mu_n^{JavaSHA1}$ with $n = 2^{26}, \dots, 2^{34}$ are presented in the Appendix Table VI. Figure 2 compares these distributions.

Fig. 2. The distributions μ_n^U and $\mu_n^{JavaSHA1}$ with $n = 2^{26}, \dots, 2^{34}$

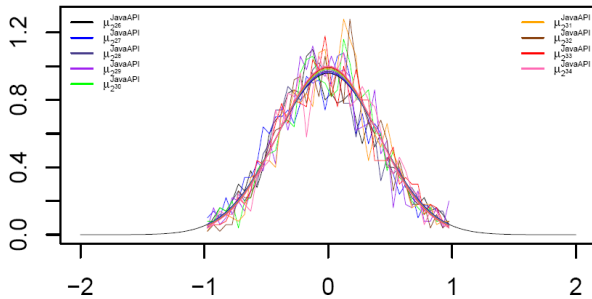


TABLE II
NUMBER OF SEQUENCES THAT PASS THE LIL VALUES 0.9 AND 0.95

N	N ₀	N ₁	N ₂	N ₃	N ₄	N ₅	N ₆	N ₇	N ₈
<i>n</i>	82	116	164	232	328	463	655	927	1310
Java SHA1PRNG									
0.9	20	16	20	20	16	14	17	11	11
-0.9	18	20	18	17	14	11	12	11	9
0.95	14	12	13	18	12	10	15	7	8
-0.95	13	13	14	9	10	7	9	8	6
NIST SP800 90A SHA1-DRBG at sample size 1000									
0.9	15	16	15	12	8	9	17	10	8
-0.9	15	19	12	18	10	16	14	9	2
0.95	10	9	12	10	5	5	11	6	6
-0.95	11	12	8	13	8	10	10	7	12
NIST SP800 90A SHA256-DRBG at sample size 1000									
0.9	13	16	14	20	13	15	21	16	9
-0.9	16	13	14	5	13	9	11	13	10
0.95	9	10	12	15	9	10	16	14	3
-0.95	13	9	8	4	8	6	9	12	9
NIST SP800 90A SHA256-DRBG at sample size 10000									
0.9	164	157	162	145	128	128	133	121	114
-0.9	154	142	142	130	123	128	123	120	107
0.95	120	107	127	110	89	93	93	84	70
-0.95	107	106	92	99	91	93	95	84	78

B. NIST SP800 90A DRBG pseudorandom generators

NIST SP800.90A [2] specifies three types of DRBG generators: hash function based, block cipher based, and ECC based. For DRBG generators, the maximum number of calls between reseeding is 2^{48} for hash function and AES based generators (the number is 2^{32} for T-DES and ECC-DRBG generators). In our experiment, we used hash function based DRBG. where a hash function G is used to generate sequences $G(V)G(V+1)G(V+2)\dots$ with V being seedlen-bit counter that is derived from the secret seeds. The seedlen is 440 for SHA1 and SHA-256 and the value of V is revised after at most 2^{19} bits are output. We generated 10000 sequences nistSHADRBG0, ..., nistSHADRBG9999. For each sequence nistSHADRBG i , the seed "ith secret seed for NIST DRBG" is used to derive the initial DRBG state V_0 and C_0 . Each sequence is of the format $G(V_0)G(V_0)\dots G(V_0+2^{12}-1)G(V_1)G(V_1+1)\dots G(V_{2^{12}}+2^{12}-1)$, where V_{i+1} is derived from the value of V_i and C_i . In other words, each V is used 2^{12} times before it is revised. The second picture (respectively, the third picture) in Figure 1 shows the LIL-test result curves for the first 100 sequences when SHA1 (respectively, SHA256) is used as the hash function and Table II shows the number of sequences that reach the value 0.9, -0.9, 0.95, and -0.95 at corresponding testing points respectively.

The probability distributions $\mu_n^{nistDRBGsha1,1000}$, $\mu_n^{nistDRBGsha256,1000}$, and $\mu_n^{nistDRBGsha256,10000}$ on partition \mathcal{B} are presented in Appendix Tables VII, VIII, IX respectively. Figure 3 compares the distributions $\mu_n^{nistDRBGsha1}$ at the sample size 1000. The comparisons for $\mu_n^{nistDRBGsha256}$ are presented in Appendix Figure 5 and 6.

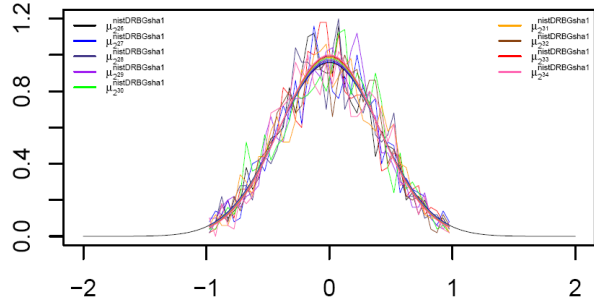
C. Comparison and Discussion

Based on Table II, the average absolute probability distance Δ_{wtil} and the root-mean-square deviation $RMSD_{wtil}$ at the sample size 1000 (for DRBG-SHA256, we also include results for sample size 10000) are calculated and shown in Table III.

TABLE III
THE PROBABILITY DISTANCES Δ_{wll} AND RMSD_{wll}

	Java SHA1PRNG	DRBG-SHA1	DRBG-SHA256 (1000)	DRBG-SHA256 (10000)
$\Delta_{wll,0.1}$	0.140	0.194	0.200	0.045
$\Delta_{wll,0.05}$	0.276	0.224	0.289	0.063
$\text{RMSD}_{wll,0.1}$	0.004647	0.003741	0.004984	0.00118
$\text{RMSD}_{wll,0.05}$	0.004042	0.003023	0.004423	0.001107

Fig. 3. The distributions μ_n^U and $\mu_n^{\text{nistDRBGsha1}}$ with $n = 2^{26}, \dots, 2^{34}$



These values are quite large.

Based on snapshot LIL tests at points $2^{26}, \dots, 2^{34}$, the corresponding total variation distance $d(\mu_n^R, \mu_n^U)$, Hellinger distance $H(\mu_n^R || \mu_n^U)$, and the root-mean-square deviation $\text{RMSD}(\mu_n^R, \mu_n^U)$ at sample size 1000 (also DRBG-SHA256 at sample size 10,000) are calculated and shown in Table IV, where subscripts 1, 2, 3, 4 are for JavaSHA1, nistDRBGsha1, nistDRBGsha256 (sample size 1000), and nistDRBGsha256 (sample size 10000) respectively. It is observed that at the sample size 1000, the average distance between μ_n^R and μ_n^U is larger than 0.06 and the root-mean-square deviation is around 0.005.

TABLE IV
TOTAL VARIATION AND HELLINGER DISTANCES

n	2^{26}	2^{27}	2^{28}	2^{29}	2^{30}	2^{31}	2^{32}	2^{33}	2^{34}
d_1	.074	.704	.064	.085	.067	.085	.074	.069	.071
H_1	.062	.067	.063	.089	.066	.078	.077	.061	.068
RMSD_1	.005	.005	.004	.005	.004	.006	.005	.005	.005
d_2	.066	.072	.079	.067	.084	.073	.065	.078	.083
H_2	.060	.070	.073	.062	.077	.066	.067	.070	.087
RMSD_2	.004	.005	.005	.004	.005	.004	.004	.005	.005
d_3	.076	.069	.072	.093	.071	.067	.078	.081	.066
H_3	.082	.064	.068	.088	.079	.073	.076	.074	.080
RMSD_3	.005	.004	.004	.006	.004	.004	.005	.005	.005
d_4	.021	.022	.026	.024	.022	.024	.026	.024	.021
H_4	.019	.021	.024	.024	.022	.023	.025	.022	.021
RMSD_4	.001	.001	.002	.001	.001	.002	.002	.002	.001

Though the statistical distances in Tables III and IV may be acceptable for various applications, for a cryptographic random source at the sample size “1000 of 2GB-long sequences”, it is expected to have a statistical distance smaller than 0.03 and an RMSD smaller than 0.001 for the standard normal distribution μ_n^U (see, e.g., [8]). At sample size 10000 of 2GB sequences, the statistical distance is reduced to 0.02 which is still more than acceptable for cryptographic applications.

One could also visually analyze the pictures in Figure 1. For example, from three pictures in Figure 1, we may get the following impression: sequences generated by Java SHA1PRNG have a good performance to stay within the interval $[-1, 1]$ though there is a big gap between 400 and 900 in the bottom area that is close to the line $y = -1$. Among the three pictures, sequences generated by SHA1-DRBG have a better performance that looks more close to a true random source. For sequences generated by SHA2-DRBG, too many sequences reach or go beyond $y = 1$ and $y = -1$ lines.

XI. CONCLUSION

This paper proposed statistical distance based LIL testing techniques and showed that, at sample size 1000, the collection of sequences generated by several commonly used pseudorandom generators has a statistical distance 0.06 and root-mean-square deviation 0.005 from a true random source. These values are larger than expected for various cryptographic applications. This paper also calculated the probability for weak LIL tests on sequences of less than 2GB. For longer sequences, the corresponding probabilities decrease significantly. Thus large sample sizes of sequences are needed for better LIL testing. Alternatively, one may also split longer sequences into independent sub-sequences of 2GB each and then use the probabilities calculated in this paper to carry out LIL testing on them. For strong LIL tests, this paper obtained a preliminary result with a very small probability for a random sequence to pass. It would be interesting to calculate the exact probability $\text{SP}_{(\alpha, \mathfrak{N})}$ for continuous interval \mathfrak{N} (e.g., $\mathfrak{N} = [2^{26}, 2^{34}]$). We believe that $\text{SP}_{(\alpha, \mathfrak{N})}$ is large enough for a reasonable interval \mathfrak{N} such as $\mathfrak{N} = [2^{26}, 2^{34}]$. When the probability $\text{SP}_{(\alpha, \mathfrak{N})}$ becomes larger, the required sample size for the strong LIL testing will be smaller. It would also be very important to find new techniques that could be used to design pseudorandom generators with smaller statistical distance and smaller root-mean-square deviation from a true random source.

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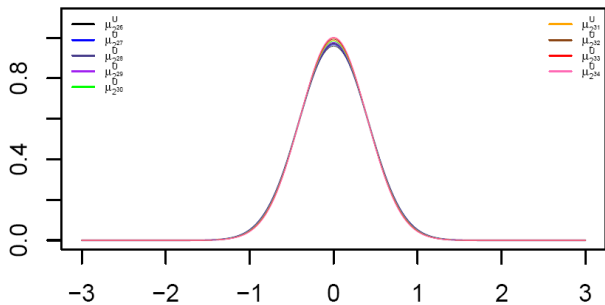
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XII. APPENDIX

Figure 4 shows the distributions of μ_n^U for $n = 2^{26}, \dots, 2^{34}$ and Table V lists values $\mu_n^U(I)$ on \mathcal{B} with $n = 2^{26}, \dots, 2^{34}$.

Fig. 4. Density functions for distributions μ_n^U with $n = 2^{26}, \dots, 2^{34}$



Since $\mu_n^U(I)$ is symmetric, it is sufficient to list the distribution in the positive side of the real line.

Table VI lists values $\mu_n^{JavaSHA1}(I)$ on \mathcal{B} with $n = 2^{26}, \dots, 2^{34}$.

Table VII lists values $\mu_n^{nistDRBsha1}(I)$ on \mathcal{B} with $n = 2^{26}, \dots, 2^{34}$.

Table VIII lists values $\mu_n^{nistDRBsha256,1000}(I)$ on \mathcal{B} with $n = 2^{26}, \dots, 2^{34}$.

Figure 5 compared the distributions $\mu_n^{nistDRBsha256,1000}$.

Fig. 5. The distributions μ_n^U and $\mu_n^{nistDRBsha256,1000}$ with $n = 2^{26}, \dots, 2^{34}$

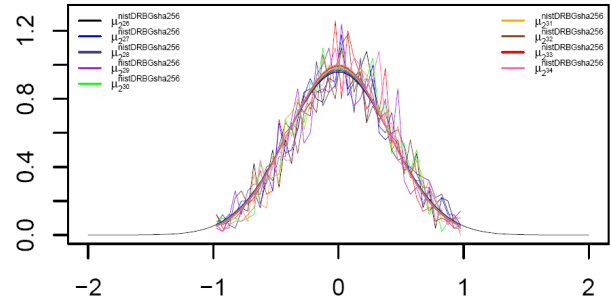


Table VIII lists values $\mu_n^{nistDRBsha256,10000}(I)$ on \mathcal{B} with $n = 2^{26}, \dots, 2^{34}$.

Figure 6 compared the distributions $\mu_n^{nistDRBsha256}$.

Fig. 6. The distributions μ_n^U and $\mu_n^{nistDRBsha256,10000}$ with $n = 2^{26}, \dots, 2^{34}$

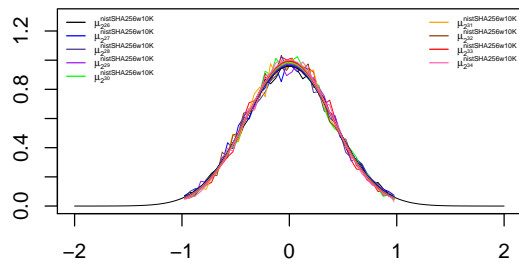


TABLE V

THE DISTRIBUTION μ_n^U INDUCED BY S_{ll} FOR $n = 2^{26}, \dots, 2^{34}$ (DUE TO SYMMETRY, ONLY DISTRIBUTION ON THE POSITIVE PART OF REAL LINE R IS GIVEN)

	2^{26}	2^{27}	2^{28}	2^{29}	2^{30}	2^{31}	2^{32}	2^{33}	2^{34}
[0.00, 0.05)	.047854	.048164	.048460	.048745	.049018	.049281	.049534	.049778	.050013
[0.05, 0.10)	.047168	.047464	.047748	.048020	.048281	.048532	.048773	.049006	.049230
[0.10, 0.15)	.045825	.046096	.046354	.046600	.046839	.047067	.047287	.047498	.047701
[0.15, 0.20)	.043882	.044116	.044340	.044553	.044758	.044953	.045141	.045322	.045496
[0.20, 0.25)	.041419	.041609	.041789	.041961	.042125	.042282	.042432	.042575	.042713
[0.25, 0.30)	.038534	.038674	.038807	.038932	.039051	.039164	.039272	.039375	.039473
[0.30, 0.35)	.035336	.035424	.035507	.035584	.035657	.035725	.035799	.035850	.035907
[0.35, 0.40)	.031939	.031976	.032010	.032041	.032068	.032093	.032115	.032135	.032153
[0.40, 0.45)	.028454	.028445	.028434	.028421	.028407	.028392	.028375	.028358	.028340
[0.45, 0.50)	.024986	.024936	.024886	.024835	.024785	.024735	.024686	.024637	.024588
[0.50, 0.55)	.021627	.021542	.021460	.021379	.021300	.021222	.021146	.021072	.020999
[0.55, 0.60)	.018450	.018340	.018234	.018130	.018029	.017931	.017836	.017743	.017653
[0.60, 0.65)	.015515	.015388	.015265	.015146	.015032	.014921	.014813	.014709	.014608
[0.65, 0.70)	.012859	.012723	.012591	.012465	.012344	.012227	.012114	.012004	.011899
[0.70, 0.75)	.010506	.010367	.010234	.010106	.009984	.009867	.009754	.009645	.009541
[0.75, 0.80)	.008460	.008324	.008195	.008072	.007954	.007841	.007733	.007629	.007530
[0.80, 0.85)	.006714	.006587	.006466	.006351	.006241	.006137	.006037	.005941	.005850
[0.85, 0.90)	.005253	.005137	.005027	.004923	.004824	.004730	.004640	.004555	.004474
[0.90, 0.95)	.004050	.003948	.003851	.003759	.003672	.003590	.003512	.003438	.003368
[0.95, 1.00)	.003079	.002990	.002906	.002828	.002754	.002684	.002617	.002555	.002495
[1.00, ∞)	.008090	.007750	.007437	.007147	.006877	.006627	.006393	.006175	.005970

TABLE VI

THE DISTRIBUTION $\mu_n^{JavaSHA1}$ INDUCED BY S_{ll} FOR $n = 2^{26}, \dots, 2^{34}$

	2^{26}	2^{27}	2^{28}	2^{29}	2^{30}	2^{31}	2^{32}	2^{33}	2^{34}
$(-\infty, -1)$.011	.008	.012	.007	.006	.006	.008	.006	.004
$[-0.1, -0.95)$.002	.005	.002	.002	.004	.001	.001	.002	.002
$[-0.95, -0.90)$.005	.007	.004	.008	.004	.004	.003	.003	.003
$[-0.90, -0.85)$.008	.005	.006	.003	.008	.005	.001	.003	.007
$[-0.85, -0.80)$.007	.011	.006	.005	.007	.006	.003	.004	.006
$[-0.80, -0.75)$.010	.006	.010	.011	.010	.005	.003	.008	.006
$[-0.75, -0.70)$.015	.010	.013	.010	.002	.004	.013	.011	.012
$[-0.70, -0.65)$.013	.017	.010	.007	.010	.006	.011	.009	.009
$[-0.65, -0.60)$.019	.017	.013	.013	.011	.017	.011	.013	.007
$[-0.60, -0.55)$.014	.021	.015	.022	.019	.018	.017	.022	.017
$[-0.55, -0.50)$.020	.032	.024	.019	.022	.022	.021	.021	.020
$[-0.50, -0.45)$.030	.030	.027	.028	.024	.022	.027	.025	.022
$[-0.45, -0.40)$.034	.035	.037	.021	.025	.020	.031	.033	.037
$[-0.40, -0.35)$.036	.035	.037	.038	.033	.037	.032	.039	.032
$[-0.35, -0.30)$.042	.037	.044	.031	.034	.035	.035	.033	.042
$[-0.30, -0.25)$.043	.033	.042	.039	.032	.043	.046	.040	.041
$[-0.25, -0.20)$.042	.039	.040	.053	.048	.039	.047	.039	.048
$[-0.20, -0.15)$.053	.047	.042	.049	.052	.042	.039	.038	.029
$[-0.15, -0.10)$.055	.045	.049	.056	.053	.038	.048	.052	.043
$[-0.10, -0.05)$.047	.046	.051	.049	.046	.054	.041	.049	.053
$[-0.05, 0)$.040	.037	.048	.047	.045	.055	.053	.059	.048
$[0, .05)$.042	.046	.050	.053	.041	.041	.041	.045	.044
$[.05, 0.10)$.039	.053	.048	.048	.043	.050	.049	.038	.049
$[0.10, 0.15)$.040	.054	.039	.049	.058	.064	.039	.050	.054
$[0.15, 0.20)$.042	.047	.039	.047	.051	.058	.064	.041	.038
$[0.20, 0.25)$.034	.030	.029	.031	.040	.053	.050	.049	.040
$[0.25, 0.30)$.027	.036	.040	.032	.041	.033	.039	.040	.044
$[0.30, 0.35)$.034	.027	.034	.033	.043	.022	.033	.040	.040
$[0.35, 0.40)$.026	.033	.030	.043	.030	.030	.030	.022	.038
$[0.40, 0.45)$.030	.030	.016	.024	.030	.026	.034	.022	.031
$[0.45, 0.50)$.020	.021	.023	.028	.019	.033	.028	.022	.021
$[0.50, 0.55)$.020	.018	.018	.008	.025	.024	.013	.026	.018
$[0.55, 0.60)$.019	.012	.020	.020	.017	.020	.022	.015	.023
$[0.60, 0.65)$.015	.015	.014	.009	.015	.015	.015	.017	.019
$[0.65, 0.70)$.011	.013	.014	.008	.010	.008	.009	.015	.013
$[0.70, 0.75)$.009	.005	.011	.013	.008	.009	.009	.015	.012
$[0.75, 0.80)$.011	.009	.007	.004	.006	.009	.009	.006	.003
$[0.80, 0.85)$.007	.008	.009	.004	.008	.009	.002	.009	.007
$[0.85, 0.90)$.008	.004	.007	.008	.004	.003	.006	.008	.007
$[0.90, 0.95)$.006	.004	.007	.002	.004	.004	.002	.004	.003
$[0.95, 1.00)$.003	.004	.002	.010	.002	.004	.004	.002	.002
$[1.00, \infty)$.011	.008	.011	.008	.010	.006	.011	.005	.006

TABLE VII
 THE DISTRIBUTION $\mu_n^{nistDRBGsha1}$ INDUCED BY S_{il} FOR $n = 2^{26}, \dots, 2^{34}$

	2^{26}	2^{27}	2^{28}	2^{29}	2^{30}	2^{31}	2^{32}	2^{33}	2^{34}
$(-\infty, -1)$.009	.008	.007	.008	.006	.007	.007	.006	.007
$[-0.1, -0.95)$.002	.004	.001	.005	.002	.003	.003	.001	.005
$[-0.95, -0.90)$.004	.007	.004	.005	.002	.006	.004	.002	.000
$[-0.90, -0.85)$.009	.006	.011	.008	.005	.003	.006	.006	.009
$[-0.85, -0.80)$.005	.010	.004	.010	.008	.003	.004	.010	.003
$[-0.80, -0.75)$.007	.004	.010	.011	.006	.008	.011	.005	.002
$[-0.75, -0.70)$.009	.005	.014	.008	.011	.017	.007	.013	.011
$[-0.70, -0.65)$.019	.014	.014	.011	.026	.015	.012	.013	.009
$[-0.65, -0.60)$.013	.020	.010	.012	.018	.011	.014	.012	.011
$[-0.60, -0.55)$.016	.021	.019	.014	.019	.022	.021	.018	.017
$[-0.55, -0.50)$.022	.018	.022	.027	.028	.022	.023	.023	.023
$[-0.50, -0.45)$.027	.025	.020	.033	.021	.029	.025	.026	.034
$[-0.45, -0.40)$.028	.030	.024	.027	.025	.033	.034	.028	.035
$[-0.40, -0.35)$.030	.036	.031	.026	.027	.026	.037	.041	.036
$[-0.35, -0.30)$.041	.032	.037	.035	.032	.026	.040	.039	.038
$[-0.30, -0.25)$.034	.043	.052	.038	.039	.032	.034	.032	.048
$[-0.25, -0.20)$.045	.031	.048	.038	.038	.046	.036	.030	.044
$[-0.20, -0.15)$.055	.044	.048	.039	.039	.042	.046	.051	.050
$[-0.15, -0.10)$.056	.058	.046	.046	.041	.050	.046	.050	.042
$[-0.10, -0.05)$.046	.048	.048	.044	.044	.051	.046	.059	.039
$[-0.05, 0)$.045	.050	.035	.051	.040	.053	.048	.059	.048
$[0, 0.05)$.045	.040	.051	.052	.047	.041	.033	.044	.042
$[0.05, 0.10)$.058	.038	.060	.047	.056	.044	.044	.056	.051
$[0.10, 0.15)$.042	.044	.035	.041	.057	.047	.050	.040	.048
$[0.15, 0.20)$.037	.040	.040	.051	.039	.049	.045	.038	.033
$[0.20, 0.25)$.034	.050	.037	.056	.045	.039	.046	.039	.033
$[0.25, 0.30)$.042	.041	.034	.046	.042	.032	.037	.039	.035
$[0.30, 0.35)$.036	.036	.040	.035	.036	.031	.043	.037	.040
$[0.35, 0.40)$.022	.038	.028	.033	.045	.029	.043	.032	.038
$[0.40, 0.45)$.029	.020	.026	.023	.037	.036	.031	.018	.034
$[0.45, 0.50)$.025	.026	.028	.023	.019	.029	.020	.019	.026
$[0.50, 0.55)$.024	.025	.034	.019	.012	.031	.024	.023	.031
$[0.55, 0.60)$.020	.012	.016	.015	.023	.020	.019	.022	.014
$[0.60, 0.65)$.010	.016	.011	.014	.013	.019	.011	.011	.015
$[0.65, 0.70)$.012	.013	.011	.008	.015	.012	.010	.013	.013
$[0.70, 0.75)$.006	.012	.011	.008	.012	.011	.011	.014	.006
$[0.75, 0.80)$.010	.011	.005	.012	.009	.006	.009	.006	.011
$[0.80, 0.85)$.006	.005	.006	.005	.006	.005	.002	.008	.006
$[0.85, 0.90)$.005	.003	.006	.003	.002	.005	.001	.007	.005
$[0.90, 0.95)$.005	.007	.003	.002	.003	.004	.006	.004	.002
$[0.95, 1.00)$.002	.004	.003	.004	.001	.001	.003	.001	.001
$[1.00, \infty)$.008	.005	.010	.007	.004	.004	.008	.005	.005

TABLE VIII
 THE DISTRIBUTION $\mu_n^{nistDRBGsha256,1000}$ INDUCED BY S_{ij} FOR $n = 2^{26}, \dots, 2^{34}$

	2^{26}	2^{27}	2^{28}	2^{29}	2^{30}	2^{31}	2^{32}	2^{33}	2^{34}
$(-\infty, -1)$.007	.005	.005	.002	.004	.003	.003	.009	.006
$[-0.1, -0.95)$.006	.004	.003	.002	.004	.003	.006	.003	.003
$[-0.95, -0.90)$.003	.004	.006	.001	.005	.003	.002	.001	.001
$[-0.90, -0.85)$.004	.006	.003	.005	.004	.005	.002	.005	.003
$[-0.85, -0.80)$.007	.006	.002	.013	.005	.007	.011	.005	.004
$[-0.80, -0.75)$.008	.010	.007	.006	.004	.008	.013	.007	.004
$[-0.75, -0.70)$.007	.010	.010	.013	.005	.004	.009	.010	.006
$[-0.70, -0.65)$.021	.013	.012	.015	.006	.018	.011	.010	.008
$[-0.65, -0.60)$.009	.008	.012	.015	.021	.009	.014	.019	.022
$[-0.60, -0.55)$.016	.019	.019	.018	.016	.008	.020	.012	.015
$[-0.55, -0.50)$.025	.013	.021	.016	.017	.023	.021	.013	.020
$[-0.50, -0.45)$.014	.033	.026	.023	.018	.015	.025	.034	.025
$[-0.45, -0.40)$.028	.024	.033	.023	.034	.034	.030	.026	.022
$[-0.40, -0.35)$.021	.025	.031	.034	.029	.036	.032	.033	.022
$[-0.35, -0.30)$.034	.031	.039	.043	.037	.040	.024	.031	.037
$[-0.30, -0.25)$.042	.041	.036	.027	.033	.031	.036	.041	.036
$[-0.25, -0.20)$.043	.046	.035	.030	.045	.039	.039	.037	.042
$[-0.20, -0.15)$.040	.042	.051	.047	.042	.044	.036	.042	.046
$[-0.15, -0.10)$.039	.042	.038	.050	.055	.044	.053	.043	.046
$[-0.10, -0.05)$.048	.046	.042	.055	.045	.050	.045	.042	.049
$[-0.05, 0)$.049	.045	.044	.043	.045	.049	.040	.063	.055
$[0, 0.05)$.055	.059	.050	.062	.049	.054	.056	.040	.043
$[0.05, 0.10)$.043	.041	.049	.044	.049	.045	.059	.060	.047
$[0.10, 0.15)$.046	.045	.036	.038	.045	.045	.042	.052	.052
$[0.15, 0.20)$.049	.046	.052	.040	.045	.049	.048	.047	.050
$[0.20, 0.25)$.054	.043	.033	.046	.046	.047	.033	.037	.043
$[0.25, 0.30)$.044	.050	.046	.041	.052	.039	.038	.040	.047
$[0.30, 0.35)$.037	.030	.032	.033	.035	.037	.034	.036	.054
$[0.35, 0.40)$.033	.028	.030	.040	.039	.033	.036	.049	.032
$[0.40, 0.45)$.025	.030	.036	.027	.024	.026	.029	.025	.033
$[0.45, 0.50)$.022	.031	.025	.043	.025	.032	.027	.028	.022
$[0.50, 0.55)$.023	.026	.021	.016	.027	.023	.018	.019	.020
$[0.55, 0.60)$.017	.017	.020	.012	.019	.017	.028	.020	.019
$[0.60, 0.65)$.024	.016	.018	.014	.025	.022	.018	.011	.015
$[0.65, 0.70)$.008	.016	.017	.009	.013	.017	.014	.007	.012
$[0.70, 0.75)$.013	.007	.016	.014	.006	.007	.014	.008	.016
$[0.75, 0.80)$.002	.009	.011	.010	.009	.011	.004	.008	.004
$[0.80, 0.85)$.011	.011	.012	.007	.001	.004	.005	.007	.007
$[0.85, 0.90)$.010	.006	.007	.003	.004	.004	.004	.004	.003
$[0.90, 0.95)$.004	.006	.002	.005	.004	.005	.005	.002	.006
$[0.95, 1.00)$.002	.003	.002	.007	.001	.002	.005	.003	.000
$[1.00, \infty)$.007	.007	.010	.008	.008	.008	.011	.011	.003

TABLE IX
 THE DISTRIBUTION $\mu_n^{nistDRBGsha256,10000}$ INDUCED BY S_{il} FOR $n = 2^{26}, \dots, 2^{34}$

	2^{26}	2^{27}	2^{28}	2^{29}	2^{30}	2^{31}	2^{32}	2^{33}	2^{34}
$(-\infty, -1)$.0071	.0070	.0062	.0067	.0061	.0066	.0069	.0053	.0055
$[-0.1, -0.95)$.0036	.0036	.0030	.0032	.0030	.0027	.0026	.0031	.0023
$[-0.95, -0.90)$.0047	.0036	.0050	.0031	.0032	.0035	.0028	.0036	.0029
$[-0.90, -0.85)$.0044	.0057	.0060	.0035	.0039	.0047	.0038	.0043	.0035
$[-0.85, -0.80)$.0063	.0068	.0058	.0085	.0057	.0062	.0066	.0062	.0050
$[-0.80, -0.75)$.0089	.0078	.0090	.0082	.0071	.0057	.0083	.0071	.0070
$[-0.75, -0.70)$.0112	.0102	.0103	.0094	.0096	.0097	.0108	.0081	.0099
$[-0.70, -0.65)$.0126	.0128	.0118	.0118	.0118	.0113	.0104	.0123	.0120
$[-0.65, -0.60)$.0149	.0147	.0166	.0166	.0151	.0147	.0185	.0144	.0147
$[-0.60, -0.55)$.0180	.0217	.0179	.0181	.0191	.0180	.0165	.0169	.0199
$[-0.55, -0.50)$.0216	.0197	.0215	.0217	.0201	.0247	.0243	.0186	.0188
$[-0.50, -0.45)$.0228	.0275	.0245	.0228	.0226	.0220	.0250	.0246	.0255
$[-0.45, -0.40)$.0274	.0303	.0310	.0309	.0292	.0283	.0319	.0302	.0287
$[-0.40, -0.35)$.0302	.0298	.0322	.0331	.0315	.0326	.0323	.0354	.0336
$[-0.35, -0.30)$.0353	.0346	.0344	.0341	.0361	.0385	.0331	.0361	.0329
$[-0.30, -0.25)$.0394	.0385	.0365	.0379	.0391	.0408	.0381	.0375	.0387
$[-0.25, -0.20)$.0435	.0405	.0391	.0425	.0462	.0375	.0454	.0442	.0446
$[-0.20, -0.15)$.0419	.0436	.0430	.0430	.0450	.0488	.0431	.0429	.0453
$[-0.15, -0.10)$.0439	.0475	.0446	.0475	.0506	.0450	.0464	.0466	.0491
$[-0.10, -0.05)$.0474	.0426	.0516	.0484	.0480	.0499	.0474	.0511	.0501
$[-0.05, 0)$.0488	.0489	.0473	.0447	.0474	.0471	.0465	.0501	.0481
$[0, 0.05)$.0497	.0478	.0499	.0460	.0499	.0505	.0495	.0507	.0485
$[0.05, 0.10)$.0466	.0460	.0470	.0493	.0512	.0465	.0474	.0476	.0469
$[0.10, 0.15)$.0436	.0478	.0479	.0455	.0475	.0481	.0466	.0468	.0494
$[0.15, 0.20)$.0450	.0455	.0467	.0438	.0436	.0459	.0487	.0472	.0469
$[0.20, 0.25)$.0435	.0411	.0389	.0440	.0418	.0466	.0407	.0460	.0431
$[0.25, 0.30)$.0393	.0395	.0392	.0406	.0414	.0390	.0407	.0381	.0405
$[0.30, 0.35)$.0370	.0351	.0325	.0377	.0334	.0341	.0357	.0348	.0352
$[0.35, 0.40)$.0319	.0304	.0323	.0321	.0289	.0300	.0290	.0363	.0347
$[0.40, 0.45)$.0308	.0286	.0295	.0309	.0264	.0274	.0271	.0300	.0293
$[0.45, 0.50)$.0239	.0235	.0249	.0252	.0251	.0243	.0243	.0241	.0257
$[0.50, 0.55)$.0203	.0229	.0184	.0219	.0213	.0226	.0219	.0201	.0202
$[0.55, 0.60)$.0166	.0177	.0166	.0154	.0192	.0168	.0189	.0158	.0178
$[0.60, 0.65)$.0162	.0150	.0160	.0163	.0167	.0154	.0138	.0127	.0144
$[0.65, 0.70)$.0137	.0143	.0145	.0119	.0120	.0122	.0123	.0123	.0111
$[0.70, 0.75)$.0102	.0103	.0111	.0092	.0109	.0103	.0104	.0088	.0091
$[0.75, 0.80)$.0074	.0087	.0089	.0074	.0082	.0079	.0084	.0080	.0070
$[0.80, 0.85)$.0081	.0070	.0075	.0068	.0060	.0063	.0069	.0050	.0067
$[0.85, 0.90)$.0059	.0057	.0047	.0058	.0033	.0050	.0037	.0050	.0040
$[0.90, 0.95)$.0044	.0050	.0035	.0035	.0039	.0035	.0040	.0037	.0044
$[0.95, 1.00)$.0032	.0037	.0033	.0024	.0021	.0027	.0026	.0023	.0015
$[1.00, \infty)$.0088	.0070	.0094	.0086	.0068	.0066	.0067	.0061	.0055